

MEMORY**Un-buffered****1 M × 64 BIT****SYNCHRONOUS DYNAMIC RAM SO-DIMM****MB8501S064AD-100/-84/-67****144-pin, 1 Clock, 1-bank, based on 1 M × 16 BIT SDRAMs with SPD****DESCRIPTION**

The Fujitsu MB8501S064AD is a fully decoded, CMOS Synchronous Dynamic Random Access Memory (SDRAM) Module consisting of four MB811171622A devices which organized as two banks of 1 M × 16 bits and a 2K-bit serial EEPROM on a 144-pin glass-epoxy substrate.

The MB8501S064AD features a fully synchronous operation referenced to a positive edge clock whereby all operations are synchronized at a clock input which enables high performance and simple user interface coexistence.

The MB8501S064AD is optimized for those applications requiring high speed, high performance and large memory storage, and high density memory organizations.

This module is ideally suited for workstations, PCs, laser printers, and other applications where a simple interface is needed.

PRODUCT LINE & FEATURES

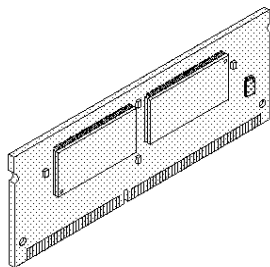
Parameter		MB8501S064AD-100	MB8501S064AD-84	MB8501S064AD-67
Clock Frequency		100 MHz max.	84 MHz max.	67 MHz max.
Burst Mode Cycle Time		10 ns max. (CL = 3) 15 ns max. (CL = 2)	12 ns max. (CL = 3) 17 ns max. (CL = 2)	15 ns max. (CL = 3) 20 ns max. (CL = 2)
$\overline{\text{RAS}}$ Access Time		54 ns max.	56 ns max.	60 ns max.
$\overline{\text{CAS}}$ Access Time		24 ns max.	26 ns max.	30 ns max.
Output Valid from Clock		8.5 ns max. (CL = 3) 9 ns max. (CL = 2)	8.5 ns max. (CL = 3) 9 ns max. (CL = 2)	9 ns max. (CL = 3) 10 ns max. (CL = 2)
Power Dissipation	Burst Mode	1944 mW max.	1800 mW max.	1620 mW max.
	Power Down Mode	28.8 mW max.		

- Un-buffered 144-pin DIMM Socket Type (Lead pitch: 0.8 mm)
- Conformed to JEDEC Standard (1 CLK)
- Organization: 1,048,576 words × 64 bits
- Memory : MB81117622A (1 M × 16, 2-bank) × 4 pcs.
- 3.3 V ±0.3 V Supply Voltage
- All input/output LVTTTL compatible
- 2048 Refresh Cycle every 32.8 ms
- Auto and Self Refresh
- CKE Power Down Mode
- DQM Byte Masking (Read/Write)
- Serial Presence Detect (SPD) with Serial EEPROM
- Module size:
1.0" (height) × 2.66" (length) × 0.15" (thick)

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■ PACKAGE

Plastic DIMM Package



(MDS-144P-P03)

Package and Ordering Information

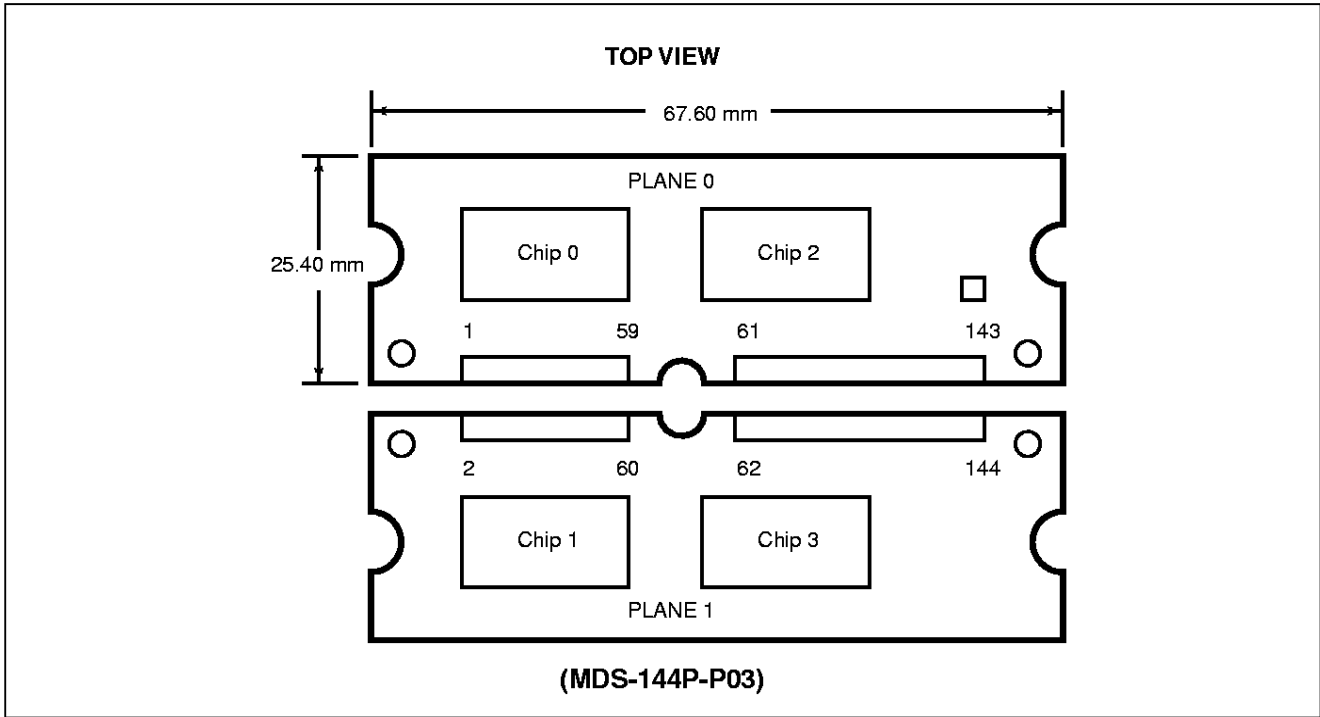
– 144-pin SO-DIMM, order as MB8501S064AD-xxDG (DG=Gold Pad)

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■ PIN ASSIGNMENTS

Pin No.	Signal Name	Pin No.	Signal Name	Pin No.	Signal Name	Pin No.	Signal Name	Pin No.	Signal Name	Pin No.	Signal Name
1	V _{SS}	49	DQ ₁₃	97	DQ ₂₂	2	V _{SS}	50	DQ ₄₅	98	DQ ₅₄
3	DQ ₀	51	DQ ₁₄	99	DQ ₂₃	4	DQ ₃₂	52	DQ ₄₆	100	DQ ₅₅
5	DQ ₁	53	DQ ₁₅	101	V _{CC}	6	DQ ₃₃	54	DQ ₄₇	102	V _{CC}
7	DQ ₂	55	V _{SS}	103	A ₆	8	DQ ₃₄	56	V _{SS}	104	A ₇
9	DQ ₃	57	N.C.	105	A ₈	10	DQ ₃₅	58	N.C.	106	A ₁₁
11	V _{CC}	59	N.C.	107	V _{SS}	12	V _{CC}	60	N.C.	108	V _{SS}
13	DQ ₄	61	CLK	109	A ₉	14	DQ ₃₆	62	CKE	110	N.C.
15	DQ ₅	63	V _{CC}	111	A ₁₀	16	DQ ₃₇	64	V _{CC}	112	N.C.
17	DQ ₆	65	$\overline{\text{RAS}}$	113	V _{CC}	18	DQ ₃₈	66	$\overline{\text{CAS}}$	114	V _{CC}
19	DQ ₇	67	$\overline{\text{WE}}$	115	DQMB ₂	20	DQ ₃₉	68	N.C.	116	DQMB ₆
21	V _{SS}	69	$\overline{\text{CS}}_0$	117	DQMB ₃	22	V _{SS}	70	N.C.	118	DQMB ₇
23	DQMB ₀	71	N.C.	119	V _{SS}	24	DQMB ₄	72	N.C.	120	V _{SS}
25	DQMB ₁	73	N.C.	121	DQ ₂₄	26	DQMB ₅	74	N.C.	122	DQ ₅₆
27	V _{CC}	75	V _{SS}	123	DQ ₂₅	28	V _{CC}	76	V _{SS}	124	DQ ₅₇
29	A ₀	77	N.C.	125	DQ ₂₆	30	A ₃	78	N.C.	126	DQ ₅₈
31	A ₁	79	N.C.	127	DQ ₂₇	32	A ₄	80	N.C.	128	DQ ₅₉
33	A ₂	81	V _{CC}	129	V _{CC}	34	A ₅	82	V _{CC}	130	V _{CC}
35	V _{SS}	83	DQ ₁₆	131	DQ ₂₈	36	V _{SS}	84	DQ ₄₈	132	DQ ₆₀
37	DQ ₈	85	DQ ₁₇	133	DQ ₂₉	38	DQ ₄₀	86	DQ ₄₉	134	DQ ₆₁
39	DQ ₉	87	DQ ₁₈	135	DQ ₃₀	40	DQ ₄₁	88	DQ ₅₀	136	DQ ₆₂
41	DQ ₁₀	89	DQ ₁₉	137	DQ ₃₁	42	DQ ₄₂	90	DQ ₅₁	138	DQ ₆₃
43	DQ ₁₁	91	V _{SS}	139	V _{SS}	44	DQ ₄₃	92	V _{SS}	140	V _{SS}
45	V _{CC}	93	DQ ₂₀	141	SDA	46	V _{CC}	94	DQ ₅₂	142	SCL
47	DQ ₁₂	95	DQ ₂₁	143	V _{CC}	48	DQ ₄₄	96	DQ ₅₃	144	V _{CC}

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■ PIN DESCRIPTION

Symbol	I/O	Function	Symbol	I/O	Function
A ₀ to A ₁₁	I	Address Input	\overline{CS}_0	I	Chip Select
\overline{RAS}	I	Row Address Strobe	DQ ₀ to DQ ₆₃	I/O	Data Input/Data Output
\overline{CAS}	I	Column Address Strobe	V _{CC}	—	Power Supply (+3.3 V)
\overline{WE}	I	Write Enable	V _{SS}	—	Ground (0 V)
DQMB ₀ to DQMB ₇	I	Data (DQ) Mask	N.C.	—	No Connection
CLK	I	Clock Input	SCL	I	Serial PD Clock
CKE	I	Clock Enable	SDA	I/O	Serial PD Address/Data Input/Output

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■ SERIAL-PD INFORMATION

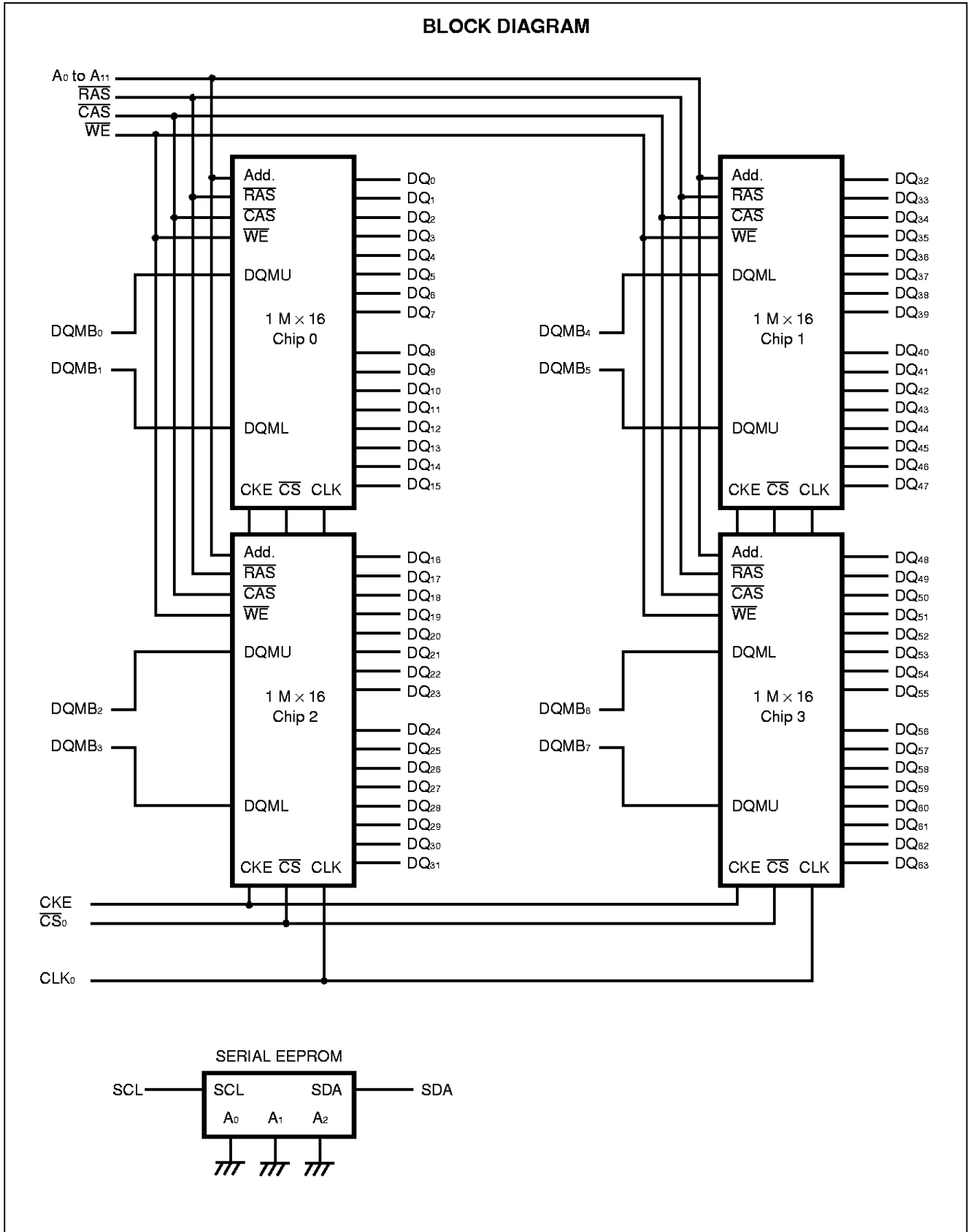
Byte	Function Described		Bit7	Bit6	Bit5	Bit4	Bit3	Bit2	Bit1	Bit0
0	Defines Number of Bytes Written into Serial Memory at Module Manufacture	128 Byte	1	0	0	0	0	0	0	0
1	Total Number of Bytes of SPD Memory	256 Byte	0	0	0	0	1	0	0	0
2	Fundamental Memory Type	SDRAM	0	0	0	0	0	1	0	0
3	Number of Row Addresses	11	0	0	0	0	1	0	1	1
4	Number of Column Addresses	8	0	0	0	0	1	0	0	0
5	Number of Module Banks	1 bank	0	0	0	0	0	0	0	1
6	Data Width	64 bit	0	1	0	0	0	0	0	0
7	Data Width (Continuation)	+0	0	0	0	0	0	0	0	0
8	Interface Type	LVTTL	0	0	0	0	0	0	0	1
9	SDRAM Cycle Time	10 ns	1	0	1	0	0	0	0	0
		12 ns	1	1	0	0	0	0	0	0
		15 ns	1	1	1	1	0	0	0	0
10	SDRAM Access from Clock	8.5 ns	1	0	0	0	0	1	0	1
		9 ns	1	0	0	1	0	0	0	0
11	DIMM Configuration Type	Non-Parity	0	0	0	0	0	0	0	0
12	Refresh Rate/Type	Self, Norm	1	0	0	0	0	0	0	0
13	SDRAM Module Attributes	UN-Buffer	0	0	0	0	0	0	0	0
14	SDRAM Device Attributes	(*)	0	0	0	0	0	1	1	0
15	Minimum Clock Delay Back to Back Random Column Address	1 Cycle	0	0	0	0	0	0	0	1
16	Burst Lengths Supported	1, 2, 4, 8	0	0	0	0	1	1	1	1
17	Number of Banks on Each SDRAM Device	2 bank	0	0	0	0	0	0	1	0
18	CAS Latency	2, 3	0	0	0	0	0	1	1	0
19	CS Latency	0	0	0	0	0	0	0	0	1
20	Write Latency	0	0	0	0	0	0	0	0	1
21 to 31	Reserved for Future Offerings	–	0	0	0	0	0	0	0	0
32 to 63	Superset Information	–	0	0	0	0	0	0	0	0
64 to 127	Manufacturer's Information	–	0	0	0	0	0	0	0	0
128+	Unused Storage Locations	–	–	–	–	–	–	–	–	–

Note: Any write operation must NOT be executed into the addresses of Byte 0 to Byte 127. Some or all data stored into Byte 0 to Byte 127 may be broken.

(*) Byte 14 : SDRAM Device Attributes

Bit7	Bit6	Bit5	Bit4	Bit3	Bit2	Bit1	Bit0
TBD	TBD	TBD	TBD	Supported Single Write/ Burst Read	Supported Precharge All	Supported Auto-Precharge	Supported Early RAS Precharge
0	0	0	0	0	1	1	0

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■ ABSOLUTE MAXIMUM RATINGS (See WARNING)

Parameter	Symbol	Value		Unit
		Min.	Max.	
Supply Voltage*	V _{CC}	-0.5	+4.6	V
Input Voltage*	V _{IN}	-0.5	+4.6	V
Output Voltage*	V _{OUT}	-0.5	+4.6	V
Storage Temperature	T _{STG}	-55	+125	°C
Power Dissipation	P _D	—	5.2	W
Output Current (D.C.)	I _{OUT}	-50	+50	mA

* : Voltages referenced to V_{SS} (= 0 V)

WARNING: Semiconductor devices can be permanently damaged by application of stress (voltage, current, temperature, etc.) in excess of absolute maximum ratings. Do not exceed these ratings.

■ RECOMMENDED OPERATING CONDITIONS

Parameter	Notes	Symbol	Value			Unit
			Min.	Typ.	Max.	
Supply Voltage	*1	V _{CC}	3.0	3.3	3.6	V
		V _{SS}	0	0	0	V
Input High Voltage, all inputs	*1	V _{IH}	2.0	—	V _{CC} +0.5	V
Input Low Voltage, all inputs	*1, 2	V _{IL}	-0.5	—	0.8	V
Ambient Temperature		T _A	0	—	+70	°C

*1. Voltages referenced to V_{SS} (= 0 V)

*2. V_{IL} (min) = -1.5 V AC (Pulse Width ≤ 5 ns)

WARNING: Recommended operating conditions are normal operating ranges for the semiconductor device. All the device's electrical characteristics are warranted when operated within these ranges.

Always use semiconductor devices within the recommended operating conditions. Operation outside these ranges may adversely affect reliability and could result in device failure.

No warranty is made with respect to uses, operating conditions, or combinations not represented on the data sheet. Users considering application outside the listed conditions are advised to contact their FUJITSU representative beforehand.

■ CAPACITANCE

(V_{CC} = +3.3 V, f = 1 MHz, T_A = +25°C)

Parameter	Symbol	Value		Unit	
		Min.	Max.		
Input Capacitance	A ₀ to A ₁₁	C _{IN1}	—	25	pF
	RAS, CAS, WE	C _{IN2}	—	25	pF
	\overline{CS}_0	C _{IN3}	—	23	pF
	CKE	C _{IN4}	—	25	pF
	CLK	C _{IN5}	—	26	pF
	DQMB ₀ to DQMB ₇	C _{IN6}	—	11	pF
	SCL	C _{SCL}	—	6	pF
Input/Output Capacitance	SDA	C _{SDA}	—	6	pF
	DQ ₀ to DQ ₆₃	C _{DQ}	—	14	pF

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■ DC CHARACTERISTICS

(At recommended operating conditions unless otherwise noted.)

Parameter	Notes	Symbol	Condition	Value		Unit	
				Min.	Max.		
Operating Current (Average Power Supply Current)	*2	MB8501S064AD-100	No Burst; $t_{CK} = \min$ $t_{RC} = \min$ One Bank Active	—	340	mA	
		MB8501S064AD-84			320	mA	
		MB8501S064AD-67			300	mA	
			MB8501S064AD-100	No Burst; $t_{CK} = \min$ $t_{RC} = \min$ All Banks Active	—	520	mA
			MB8501S064AD-84			480	mA
			MB8501S064AD-67			440	mA
Precharge Standby Current (Power Supply Current)	*2	I_{CC2P}	CKE = V_{IL} , $t_{CK} = \min$ All Banks Idle	—	8	mA	
		I_{CC2N}	CKE = V_{IH} , $t_{CK} = \min$ All Banks Idle	—	120	mA	
Active Standby Current (Power Supply Current)	*2	I_{CC3P}	CKE = V_{IL} , $t_{CK} = \min$ Any Bank Active	—	120	mA	
		I_{CC3N}	CKE = V_{IH} , $t_{CK} = \min$ Any Bank Active	—	200	mA	
Burst Mode Current (Average Power Supply Current)	*2	MB8501S064AD-100	I_{CC4} $t_{CK} = \min$	—	540	mA	
		MB8501S064AD-84			500	mA	
		MB8501S064AD-67			460	mA	
Auto-Refresh Current (Average Power Supply Current)	*2	MB8501S064AD-100	I_{CC5} Auto Refresh $t_{CK} = \min$ $t_{RC} = \min$ $t_{BRD} = \min$	—	440	mA	
		MB8501S064AD-84			400	mA	
		MB8501S064AD-67			360	mA	
Self-Refresh Current (Average Power Supply Current)		I_{CC6}	$t_{CK} = V_{IL}$	—	8	mA	
Input Leakage Current (All Inputs)		$I_{I(L)}$	$0V \leq V_{IN} \leq V_{CC}$ All other pins not under test = 0V $3.0V \leq V_{CC} \leq 3.6V$	-30	30	μA	
Output Leakage Current		$I_{O(L)}$	Output is disabled (Hi-Z) $0V \leq V_{OUT} \leq V_{CC}$ $3.0V \leq V_{CC} \leq 3.6V$	-10	10	μA	
LVTTL Output High Voltage	*1	V_{OH}	$I_{OH} = -2.0\text{ mA}$	2.4	—	V	
LVTTL Output Low Voltage	*1	V_{OL}	$I_{OL} = +2.0\text{ mA}$	—	0.4	V	

Notes: *1. Voltages referenced to V_{SS} (= 0V)

*2. I_{CC} depends on the output termination, load conditions, clock cycle rate and signal clock rate.
The specified values are obtained with the output open and no termination register.

*3. An initial pause (DESL on NOP) of 200 μs is required after power-on followed by a minimum of eight Auto-Refresh cycles.

*4. DC characteristics is the Serial PD standby state ($V_{IN} = GND$ or V_{CC}).

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■ AC CHARACTERISTICS

(1) BASE CHARACTERISTICS

(At recommended operating conditions unless otherwise noted.)

No.	Parameter	Notes	Symbol	MB8501S064AD -100		MB8501S064AD -84		MB8501S064AD -67		Unit
				Min.	Max.	Min.	Max.	Min.	Max.	
1	Clock Period	CL = 3	t _{CK}	10	—	12	—	15	—	ns
		CL = 2		15	—	17	—	20	—	ns
2	Clock High Time		t _{CH}	4	—	4	—	4	—	ns
3	Clock Low Time		t _{CL}	4	—	4	—	4	—	ns
4	$\overline{\text{CS}}$ Set Up Time		t _{SC}	3	—	3	—	3	—	ns
5	$\overline{\text{CS}}$ Hold Time		t _{HC}	1	—	1	—	1	—	ns
6	Input Set Up Time		t _{SI}	3	—	3	—	3	—	ns
7	Input Hold Time		t _{HI}	1	—	1	—	1	—	ns
8	Data Input Set Up Time		t _{SID}	3	—	3	—	3	—	ns
9	Data Input Hold Time		t _{HID}	1	—	1	—	1	—	ns
10	Output Valid from Clock (t _{CLK} = min)	*1, *2	t _{AC}	—	8.5	—	8.5	—	9	ns
				—	9	—	9	—	10	
11	Output in Low-Z		t _{OLZ}	3	—	3	—	3	—	ns
12	Output in High-Z	*3	t _{OHZ}	3	—	3	—	3	—	ns
13	Output Hold Time		t _{OH}	3	—	3	—	3	—	ns
14	Time between Refresh		t _{REF}	—	32.8	—	32.8	—	32.8	ms
15	Transition Time		t _T	0.5	2	0.5	2	0.5	2	ns
16	Power Down Exit Time		t _{PDE}	3	—	4	—	5	—	ns

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(2) BASE VALUES FOR CLOCK COUNT/LATENCY

No.	Parameter	Notes	Symbol	MB8501S064AD -100		MB8501S064AD -84		MB8501S064AD -67		Unit
				Min.	Max.	Min.	Max.	Min..	Max.	
1	$\overline{\text{RAS}}$ Cycle Time	*4	t _{RC}	90	—	100	—	110	—	ns
2	$\overline{\text{RAS}}$ Access Time	*5	t _{RAC}	—	54	—	56	—	60	ns
3	$\overline{\text{CAS}}$ Access Time	*6, *9	t _{CAC}	—	24	—	26	—	30	ns
4	$\overline{\text{RAS}}$ Precharge Time		t _{RP}	30	—	35	—	40	—	ns
5	$\overline{\text{RAS}}$ Active Time		t _{RAS}	60	100000	65	100000	70	100000	ns
6	$\overline{\text{RAS}}$ to $\overline{\text{CAS}}$ Delay Time	*7	t _{RCD}	30	—	30	—	30	—	ns
7	Write Recovery Time		t _{WR}	10	—	12	—	15	—	ns
8	Write Precharge Time		t _{RWL}	10	—	12	—	15	—	ns
9	$\overline{\text{RAS}}$ to $\overline{\text{CAS}}$ Bank Active Delay Time		t _{BRD}	30	—	30	—	30	—	ns

(3) CLOCK COUNT FORMULA (*8)

$$\text{Clock} \geq \frac{\text{Base Value}}{\text{Clock Period}} \quad (\text{Round off a whole number})$$

(4) LATENCY (The latency values on these parameters are fixed regardless of clock period.)

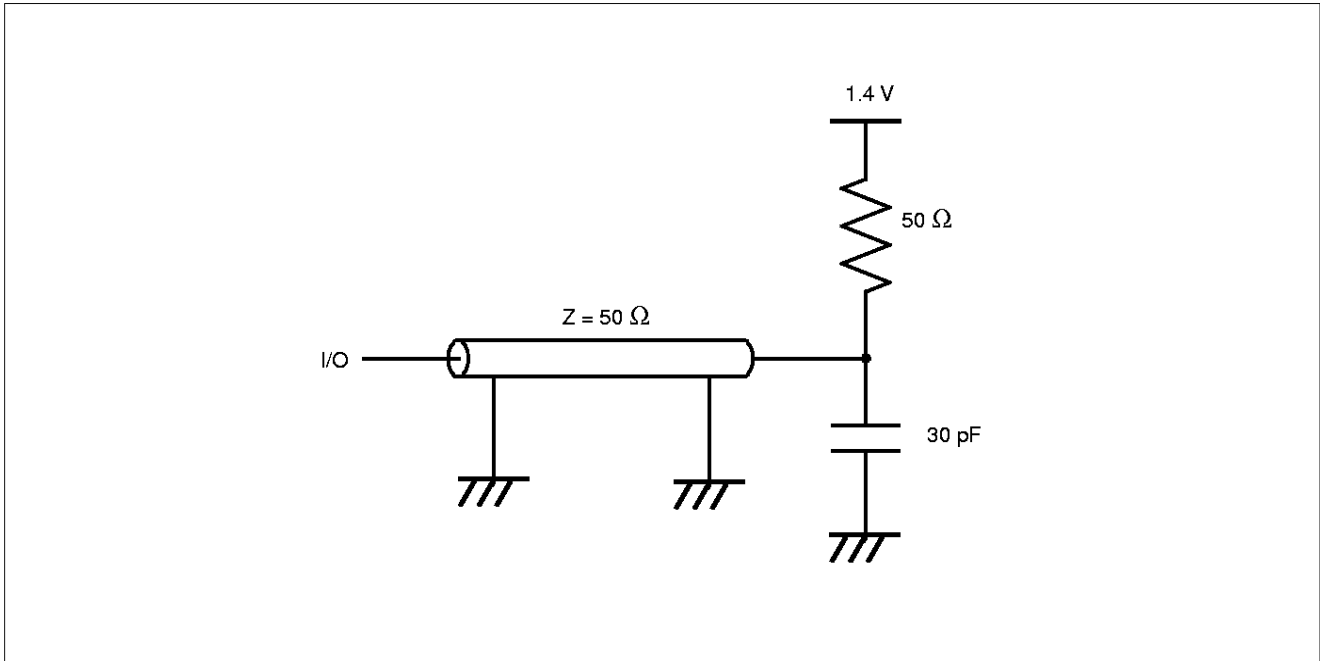
No.	Parameter	Symbol	MB8501S064AD -100	MB8501S064AD -84	MB8501S064AD -67	Unit
1	CKE to Clock Disable	t _{CKE}	1	1	1	Cycle
2	DQM to Output In High-Z	t _{DOZ}	2	2	2	Cycle
3	DQM to Input Data Delay	t _{DOD}	0	0	0	Cycle
4	Last Output to Write Command Delay	t _{LOWD}	2	2	2	Cycle
5	Write Command to Input Data Delay	t _{LDWD}	0	0	0	Cycle
6	Precharge to Output in High-Z Delay	CL = 3	3	3	3	Cycle
		CL = 2	2	2	2	Cycle
7	Mode Register Access to Bank Active (min)	t _{MRD}	2	2	2	Cycle
8	$\overline{\text{CAS}}$ to $\overline{\text{CAS}}$ Delay (min)	t _{CCD}	1	1	1	Cycle
9	$\overline{\text{CAS}}$ Bank Delay (min)	t _{CBD}	1	1	1	Cycle

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- Notes:**
- *1. Assumes t_{RCD} and t_{CAC} are satisfied.
 - *2. t_{AC} also specifies the access time at burst mode except for first access.
 - *3. Specified where output buffer is no longer driven.
 - *4. Actual clock count of t_{RC} (I_{RC}) will be sum of clock count of t_{RAS} (I_{RAS}) and t_{RP} (I_{RP}).
 - *5. t_{RAC} is a reference value. Maximum value is obtained from the sum of t_{RCD} (min) and t_{CAC} (max).
 - *6. Assumes t_{RAC} and t_{AC} are satisfied.
 - *7. Operation within the t_{RCD} (min) ensures that t_{RAC} can be met; if t_{RCD} is greater than the specified t_{RCD} (min), access time is determined by t_{CAC} and t_{AC} .
All clock counts are calculated by a simple formula:
clock count equals base value divided by clock period (round off to a whole number).
 - *9. The t_{CAC} (CAS latency: CL) is programmed by the mode register.
 - *10. An initial pause (DESL on NOP) of 200 μ s is required after power-up followed by a minimum of eight Auto-Refresh cycles.
 - *11. 1.4 V or V_{REF} is the reference level for measuring timing of signals.
Transition times are measured between V_{IH} (min) and V_{IL} (max).
 - *12. AC characteristics assume $t_T = 1$ ns and 30 pF of capacitive load.
- *Source: See MB811171622A Data Sheet for details on the electricals.

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■ AC OPERATING TEST CONDITION (Example of AC Test Load Circuit)



■ SERIAL PRESENCE DETECT (SPD) FUNCTION

1. PIN DESCRIPTIONS

SCL (Serial Clock)

SCL input is used to clock all data input/output of SPD

SDA (Serial Data)

SDA is a common pin used for all data input/output of SPD. The SDA pull-up resistor is required due to the open-drain output.

SA₀, SA₁, SA₂ (Address)

Address inputs are used to set the least significant three bits of the eight bits slave address. The address inputs must be fixed to select a particular module and the fixed address of each module must be different each other. For this module, any address inputs are not required because all addresses (SA₀, SA₁, SA₂) are driven to V_{SS} on the module.

2. SPD OPERATIONS

CLOCK and DATA CONVENTION

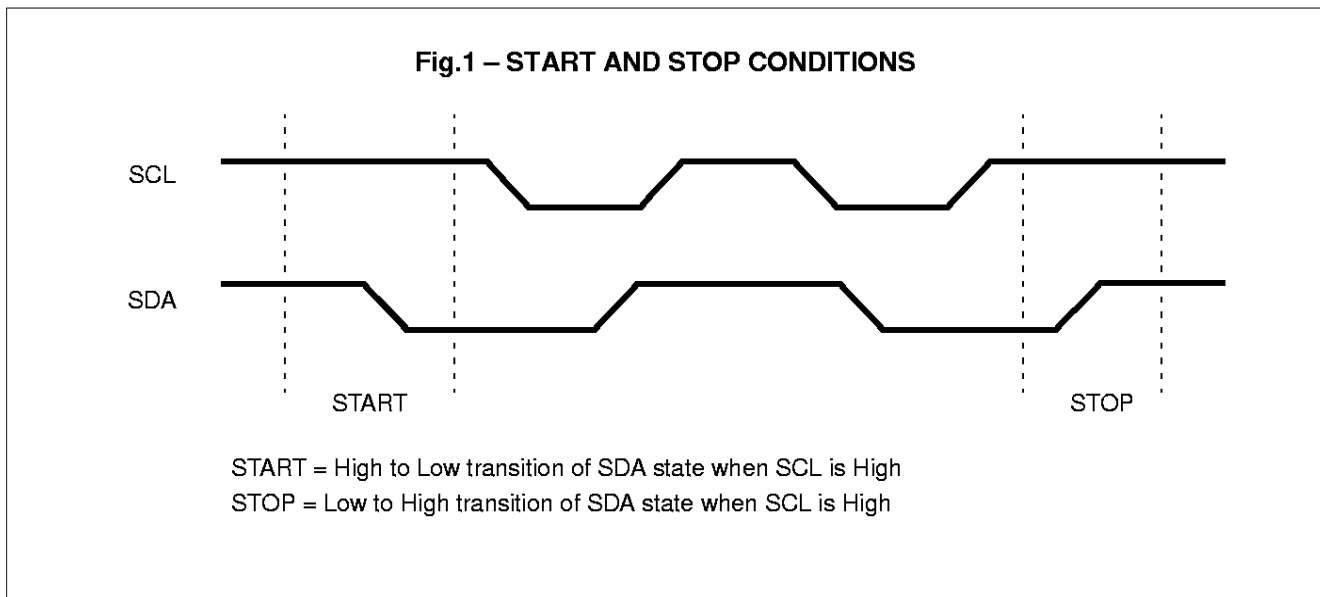
Data states on the SDA can change only during SCL=Low. SDA state changes during SCL=High are indicated start and stop conditions. Refer to Fig.1 below.

START CONDITION

All commands are preceded by a start condition, which is a transition of SDA state from High to Low when SCL=High. SPD will not respond to any command until this condition has been met.

STOP CONDITION

All read or write operation must be terminated by a stop condition, which is a transition of SDA state from Low to High when SCL=High. The stop condition is also used to make the SPD into the state of standby power mode after a read sequence.



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ACKNOWLEDGE

Acknowledge is a software convention used to indicate successful data transfer. The transmitting device, either master or slave, will release the bus after transmitting eight bits. During the ninth clock cycle the receiver will put the SDA line to Low in order to acknowledge that it received the eight bits of data.

The SPD will respond with an acknowledge when it received the start condition followed by slave address issued by master.

In the read operation, the SPD will transmit eight bits of data, release the SDA line and monitor the line for an acknowledge. If an acknowledge is detected and no stop condition is issued by master, the SPD will continue to transmit data. If an acknowledge is not detected, the SPD will terminated further data transmissions. The master must then issue a stop condition to return the SPD to the standby power mode.

In the write operation, upon receipt of eight bits of data the SPD will respond with an acknowledge, and await the next eight bits of data, again responding with an acknowledge until the stop condition is issued by master.

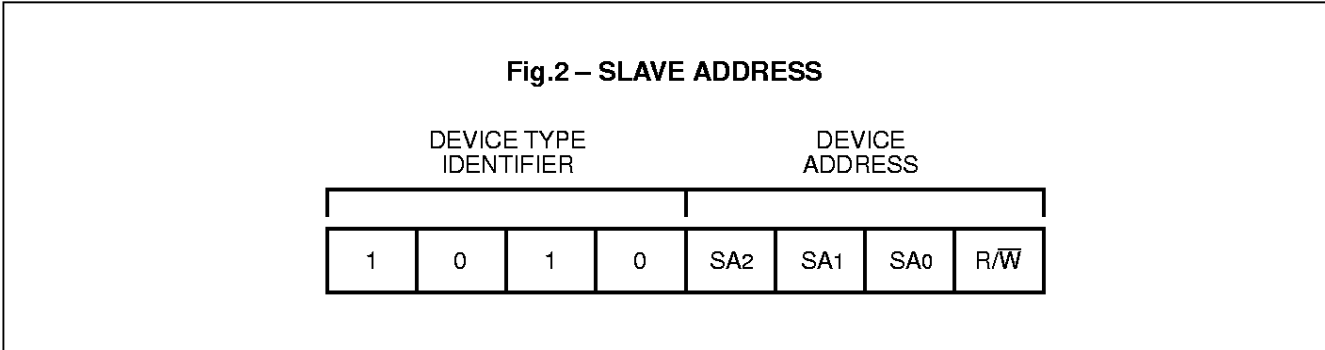
SLAVE ADDRESS ADDRESSING

Following a start condition, the master must output the eight bits slave address. The most significant four bits of the slave address are device type identifier. For the SPD this is fixed as 1010[B]. Refer to the Fig.2 below.

The next three significant bits are used to select a particular device. A system could have up to eight SPD devices—namely up to eight modules—on the bus. The eight addresses for eight SPD devices are defined by the state of the SA₀, SA₁ and SA₂ inputs. For this module, the three bits are fixed as 000[B] because all addresses are driven to V_{SS} on the module. Therefore, no address inputs are required.

The last bit of the slave address defines the operation to be performed. When R/ \bar{W} bit is “1”, a read operation is selected, when R/ \bar{W} bit is “0”, a write operation is selected.

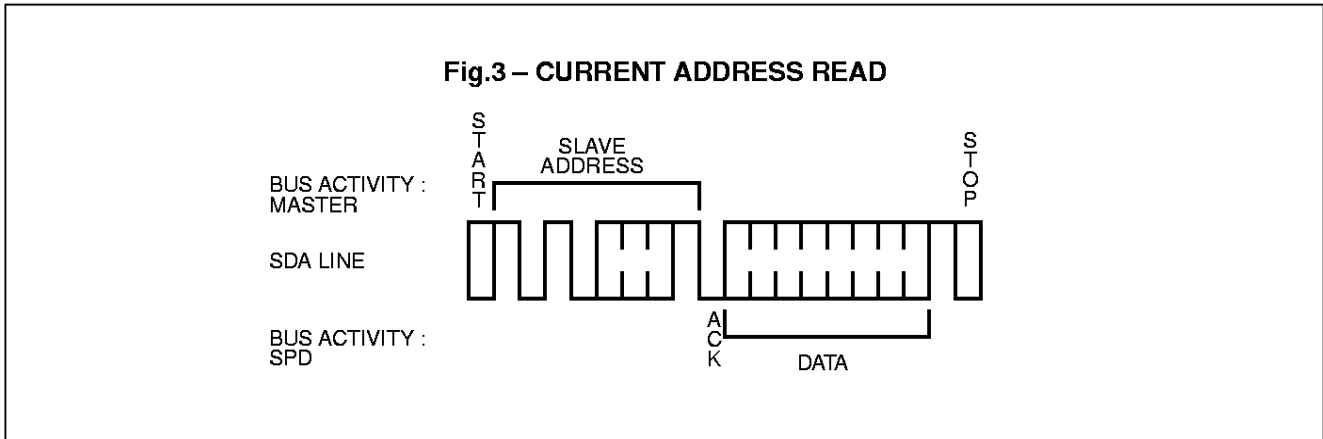
Following the start condition, the SPD monitors the SDA line comparing the slave address being transmitted with its slave address (device type and state of SA₀, SA₁, and SA₂ inputs). Upon a correct compare the SPD outputs an acknowledge on the SDA line. Depending on the state of the R/ \bar{W} bit, the SPD will execute a read or write operation.



3. READ OPERATION

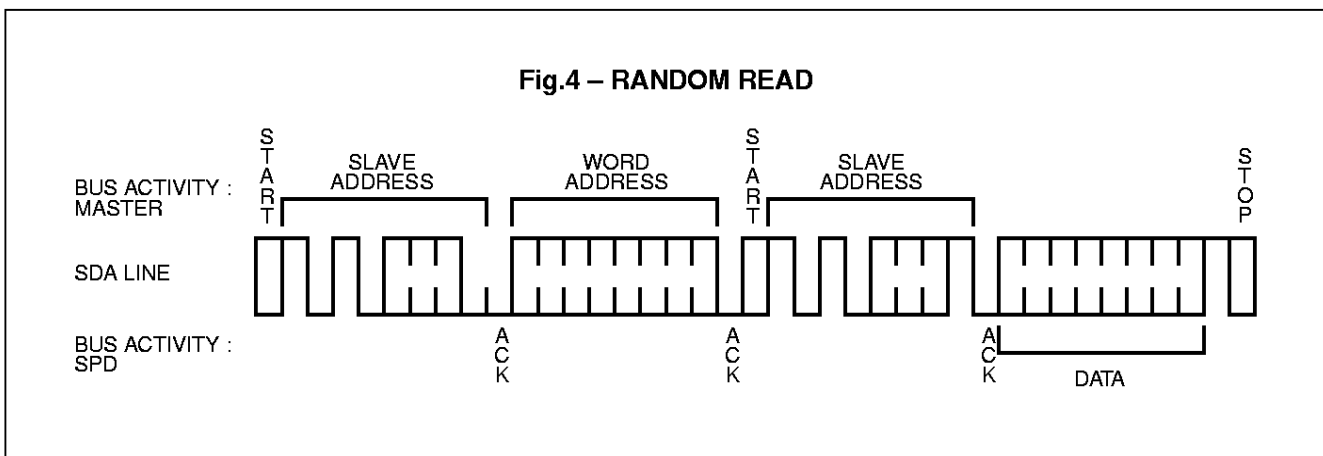
CURRENT ADDRESS READ

Internally the SPD contains an address counter that maintains the address of the last data accessed, incremented by one. Therefore, if the last access (either a read or write operation) was to address(n), the next read operation would access data from address(n+1). Upon receipt of the slave address with the R/\overline{W} bit = "1", the SPD issues an acknowledge and transmits the eight bits of data during the next eight clock cycles. The master terminates this transmission by issuing a stop condition, omitting the ninth clock cycle acknowledge. Refer to Fig.3 for the sequence of address, acknowledge and data transfer.



RANDOM READ

Random Read operations allow the master to access any memory location in a random manner. Prior to issuing the slave address with the R/\overline{W} bit = "1", the master must first perform a "dummy" write operation on the SPD. The master issues the start condition, and the slave address followed by the word address. After the word address acknowledge, the master immediately reissues the start condition and the slave address with the R/\overline{W} bit = "1". This will be followed by an acknowledge from the SPD and then by the eight bits of data. The master terminates this transmission by issuing a stop condition, omitting the ninth clock cycle acknowledge. Refer to Fig.4 for the sequence of address, acknowledge and data transfer.

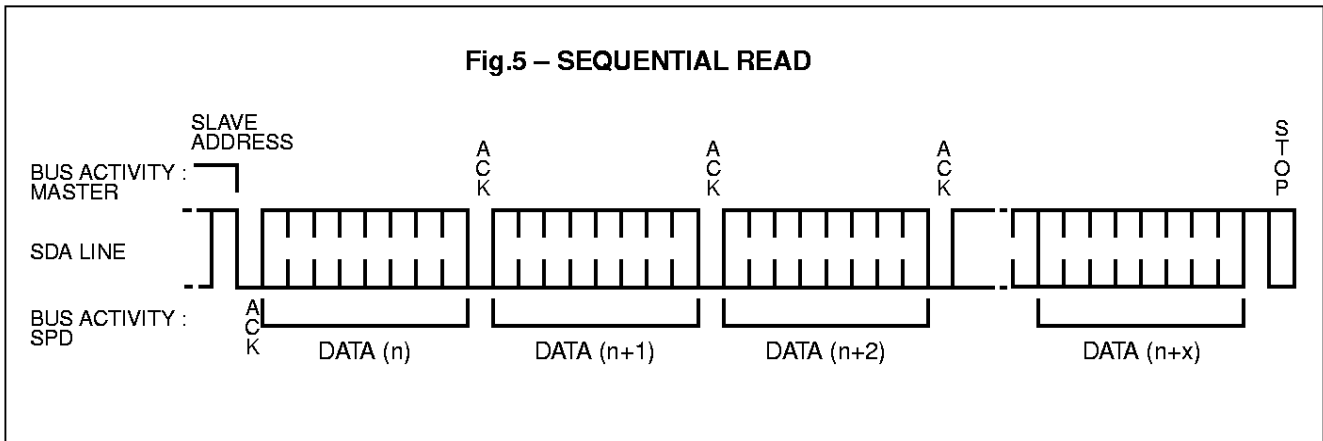


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SEQUENTIAL READ

Sequential Read can be initiated as either a current address read or random read. The first data are transmitted as with the other read mode, however, the master now responds with an acknowledge, indicating it requires additional data. The SPD continues to output data for each acknowledge received. The master terminates this transmission by issuing a stop condition, omitting the ninth clock cycle acknowledge. Refer to Fig.5 for the sequence of address, acknowledge and data transfer.

The data output is sequential, with the data from address(n) followed by the data from address(n+1). The address counter for read operations increments all address bits, allowing the entire memory contents to be serially read during one operation. At the end of the address space (address 255), the counter “rolls over” to address 0 and the SPD continues to output data for each acknowledge received.



4. DC CHARACTERISTICS

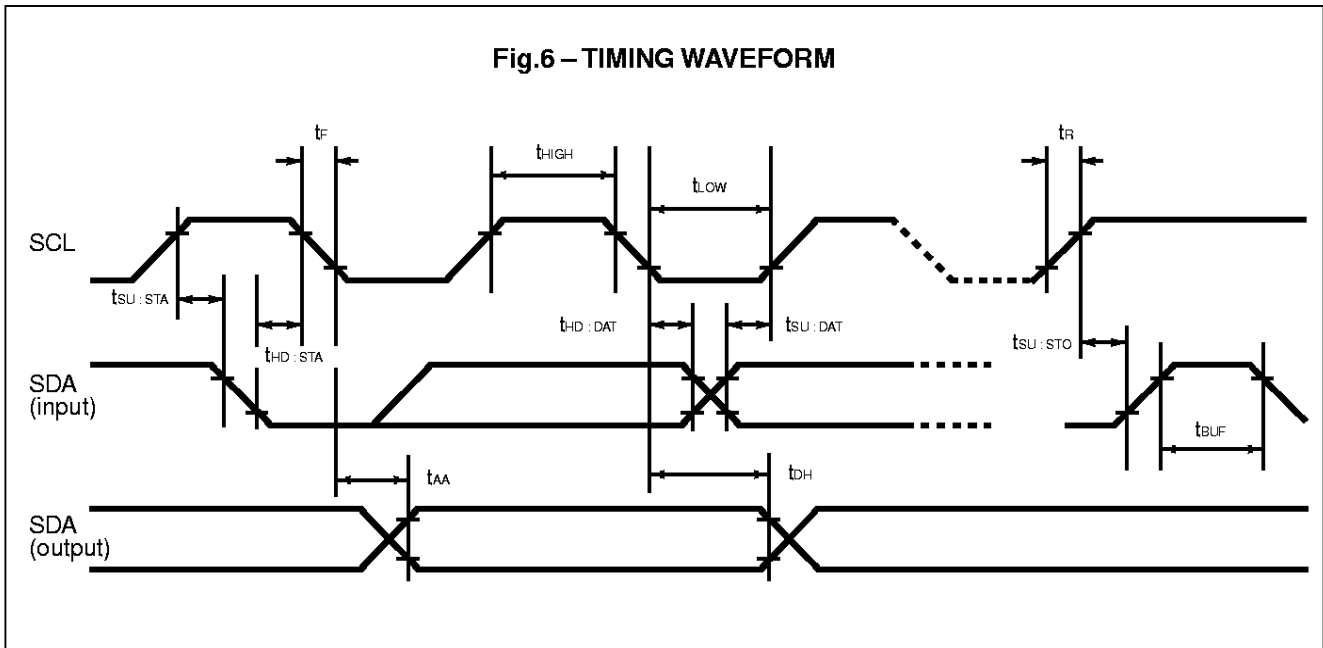
Parameter	Note	Symbol	Condition	Value		Unit
				Min.	Max.	
Input Leakage Current		S_{ILI}	$0\text{ V} \leq V_{IN} \leq V_{CC}$	-10	10	μA
Output Leakage Current		S_{ILO}	$0\text{ V} \leq V_{OUT} \leq V_{CC}$	-10	10	μA
Output Low Voltage	*1	S_{VOL}	$I_{OL} = 3.0\text{ mA}$	—	0.4	V

*1. Referenced to V_{SS} .

5. AC CHARACTERISTICS

No.	Parameter	Symbol	Value		Unit
			Min.	Max.	
1	SCL Clock Frequency	f_{SCL}	0	100	KHz
2	Noise Suppression Time Constant at SCL, SDA Inputs	T_I	—	100	ns
3	SCL Low to SDA Data Out Valid	t_{AA}	—	3.5	μs
4	Time the Bus Must Be Free Before a New Transmission Can Start	t_{BUF}	4.7	—	μs
5	Start Condition Hold Time	$t_{HD:STA}$	4.0	—	μs
6	Clock Low Period	t_{LOW}	4.7	—	μs
7	Clock High Period	t_{HIGH}	4.0	—	μs
8	Start Condition Set Up Time	$t_{SU:STA}$	4.7	—	μs
9	Data In Hold Time	$t_{HD:DAT}$	0	—	μs
10	Data In Set Up Time	$t_{SU:DAT}$	250	—	ns
11	SDA and SCL Rise Time	t_R	—	1	μs
12	SDA and SCL Fall Time	t_F	—	300	ns
13	Stop Condition Set Up Time	$t_{SU:STO}$	4.7	—	μs
14	Data Out Hold Time	t_{DH}	100	—	ns
15	Write Cycle Time	t_{WR}	—	15	ms

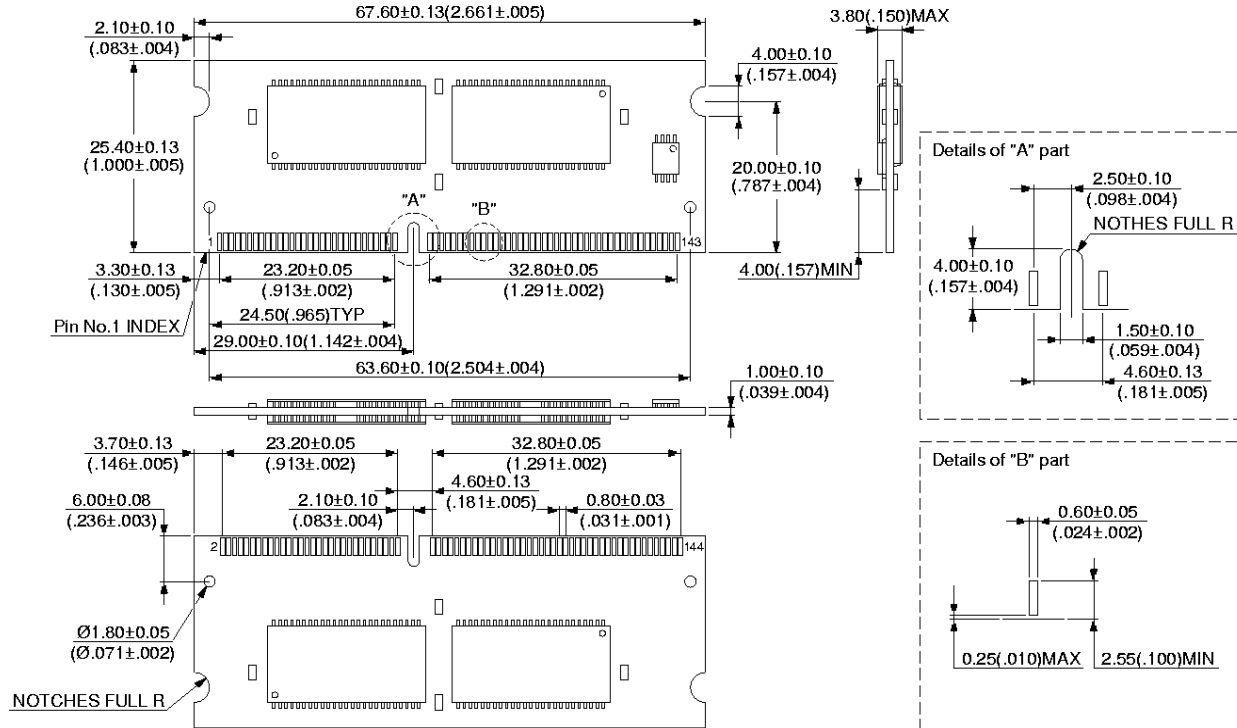
Fig.6 – TIMING WAVEFORM



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PACKAGE DIMENSION

144-PIN SMALL OUTLINE DUAL IN-LINE MEMORY MODULE (CASE No.: MDS-144P-P03)



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Dimension in mm (inches)

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